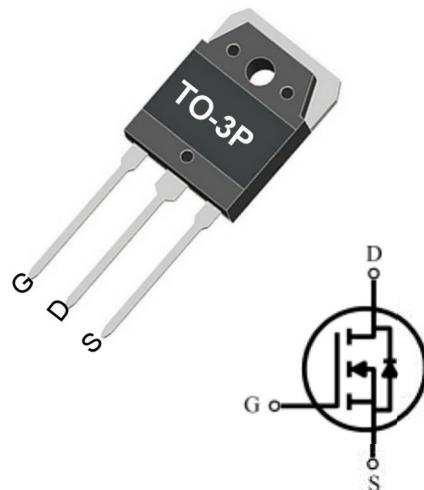


## 500V N-Channel MOSFET

### ■ Features

- $V_{DSS}=500V$     $I_D=18A$
- $R_{DS(ON)}=0.295\Omega$ (max.)@ $V_{GS}=10V$
- Low On-Resistance
- Excellent CdV/dt effect decline
- Super Low Gate Charge
- 100% EAS Guaranteed
- Fast switching speed

### ■ PIN DESCRIPTION



### ■ Applications

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

| Part Number | Package | Marking  | ROHS Status | Packing   |
|-------------|---------|----------|-------------|-----------|
| SI18N50P    | TO-3P   | SI18N50P | ROHS        | Box(Tube) |

### ■ Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

| Symbol         | Parameter  | Value      | Unit |
|----------------|--|------------|------|
| $V_{DS}$       | Drain-Source Voltage                             | 500        | V    |
| $V_{GS}$       | Gate-Source Voltage                              | $\pm 30$   | V    |
| $I_D$          | Continuous Drain Current                         | 18         | A    |
| $I_{DM}$       | Pulsed Drain Current                             | 76         | A    |
| $I_{AR}$       | Avalanche Current                                | 19         | A    |
| $E_{AS}$       | Single Pulse Avalanche Energy                    | 945        | mJ   |
| $T_J, T_{stg}$ | Operating Junction and Storage Temperature Range | -55 to 150 | °C   |
| $P_D$          | Total Power Dissipation                          | 239        | W    |

### ■ THERMAL RESISTANCE RATINGS

| Symbol          | Parameter                   | Value | Unit |
|-----------------|-----------------------------|-------|------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient | 40    | °C/W |
| $R_{\theta JC}$ | Maximum Junction-to-Case    | 0.52  |      |

## Electrical Characteristics (TJ=25°C unless otherwise Ratings )

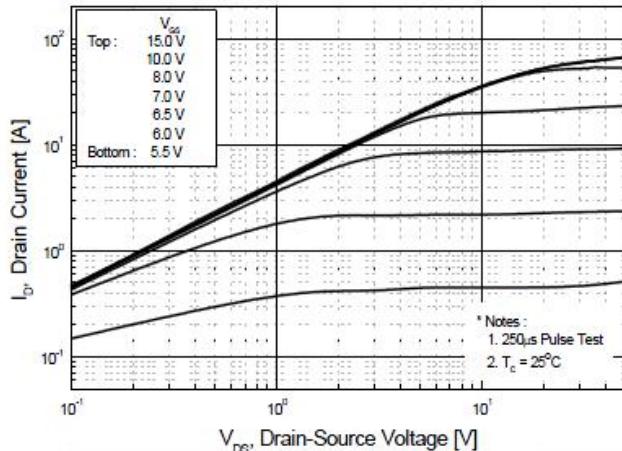
| Symbol                        | Parameter                        | Test Conditions   | Min. | TYP. | Max.  | Unit |
|-------------------------------|----------------------------------|---|------|------|-------|------|
| <b>Static Characteristics</b> |                                  |   |      |      |       |      |
| B <sub>VDS</sub>              | Drain-source breakdown voltage   | V <sub>GS</sub> =0V,I <sub>DS</sub> = 250uA                       | 500  | -    | -     | V    |
| V <sub>GS(th)</sub>           | Gate threshold voltage           | V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>DS</sub> =250uA          | 2    | -    | 4     | V    |
| I <sub>DSS</sub>              | Drain-Source Leakage Current     | V <sub>DS</sub> =500V,V <sub>GS</sub> =0V                         | -    | -    | 1     | uA   |
|                               |                                  | V <sub>DS</sub> =400V,V <sub>GS</sub> =0V,T <sub>C</sub> =125°C   | -    | -    | 10    | uA   |
| I <sub>GSS</sub>              | Gate-source leakage current      | V <sub>DS</sub> =0V,V <sub>GS</sub> =±30V                         | -    | -    | ±100  | nA   |
| R <sub>DS(on)</sub>           | Drain-source on-state resistance | V <sub>GS</sub> =10V,I <sub>D</sub> =10A                          | -    | -    | 0.295 | Ω    |
| <b>Dynamic Characteristic</b> |                                  |   |      |      |       |      |
| Q <sub>g</sub>                | Total Gate Charge                | V <sub>GS</sub> =10V,V <sub>DD</sub> =400V<br>I <sub>D</sub> =20A | -    | 45.5 | -     | nC   |
| Q <sub>gs</sub>               | Gate-Source Charge               |   | -    | 15.8 | -     | nC   |
| Q <sub>gd</sub>               | Gate-Drain Charge                |   | -    | 21.6 | -     | nC   |
| T <sub>d(on)</sub>            | Turn-on delay time               | I <sub>D</sub> =20A,V <sub>DD</sub> =250V,<br>R <sub>G</sub> =25Ω | -    | 55   | -     | nS   |
| T <sub>r</sub>                | Rise time                        |   | -    | 165  | -     | nS   |
| T <sub>d(off)</sub>           | Turn-off delay time              |   | -    | 95   | -     | nS   |
| T <sub>f</sub>                | Fall time                        |   | -    | 90   | -     | nS   |
| C <sub>iss</sub>              | Input Capacitance                | V <sub>GS</sub> =0V,V <sub>DS</sub> =25V<br>f=1.0MHz              | -    | 2200 | -     | pF   |
| C <sub>oss</sub>              | Output Capacitance               |   | -    | 330  | -     | pF   |
| C <sub>rss</sub>              | Reverse Transfer Capacitance     |   | -    | 25   | -     | pF   |
| <b>Source-Drain Diode</b>     |                                  |   |      |      |       |      |
| V <sub>SD</sub>               | Diode Forward Voltage            | V <sub>GS</sub> =0V,I <sub>SD</sub> =20A                          | -    | -    | 1.4   | V    |
| I <sub>SM</sub>               | Pulsed Source Current            | V <sub>G</sub> =V <sub>D</sub> =0V,T <sub>C</sub> =25°C           | -    | -    | 76    | A    |
| I <sub>S</sub>                | Continuous Source Current        |   | -    | -    | 19    | A    |
| T <sub>rr</sub>               | Reverse Recovery Time            | V <sub>GS</sub> =0V,I <sub>S</sub> =20A,<br>dI/dt=100A /μs        | -    | 500  | -     | ns   |
| Q <sub>rr</sub>               | Reverse Recovery Charge          |   | -    | 5.4  | -     | uC   |

### Notes:

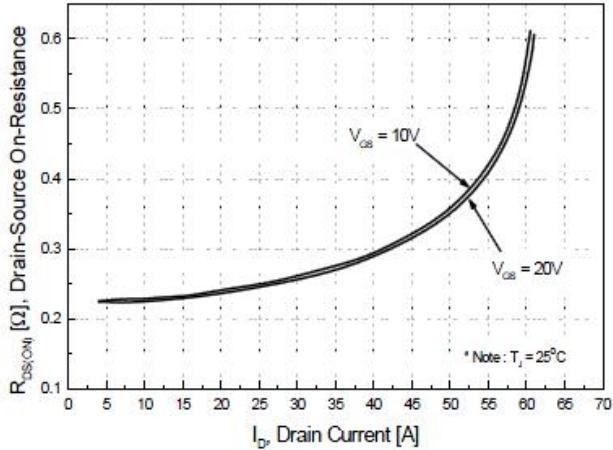
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2% .

## Typical Performance Characteristics

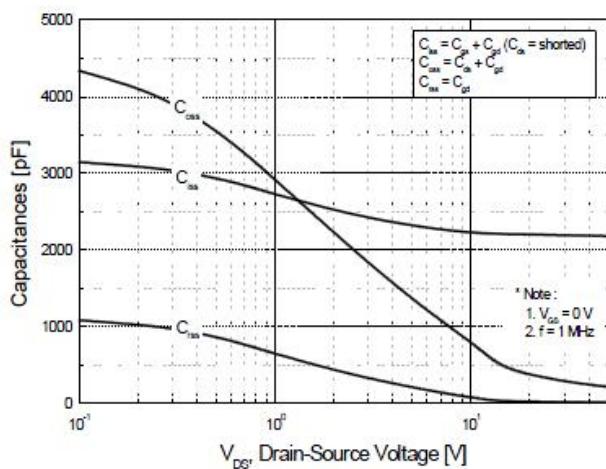
**Figure 1. On-Region Characteristics**



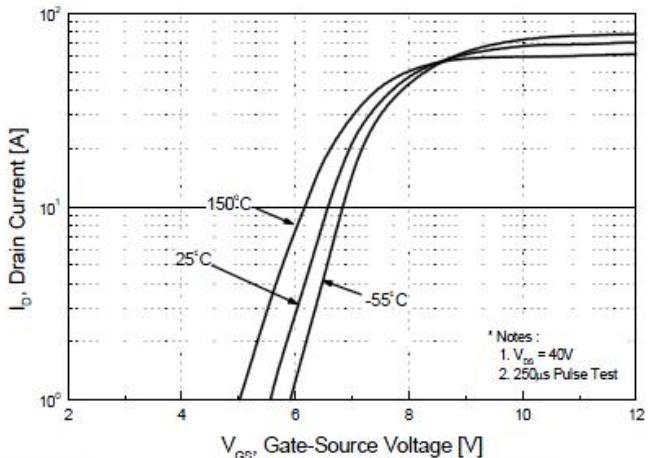
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



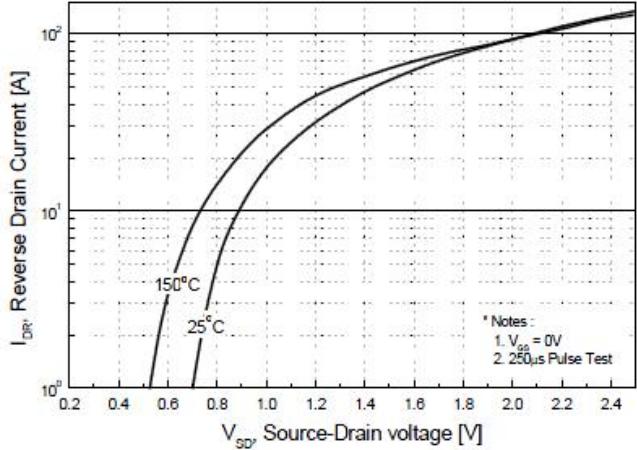
**Figure 5. Capacitance Characteristics**



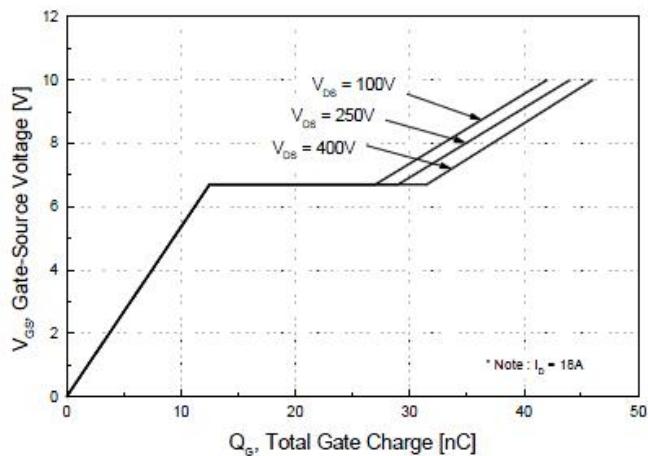
**Figure 2. Transfer Characteristics**



**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**

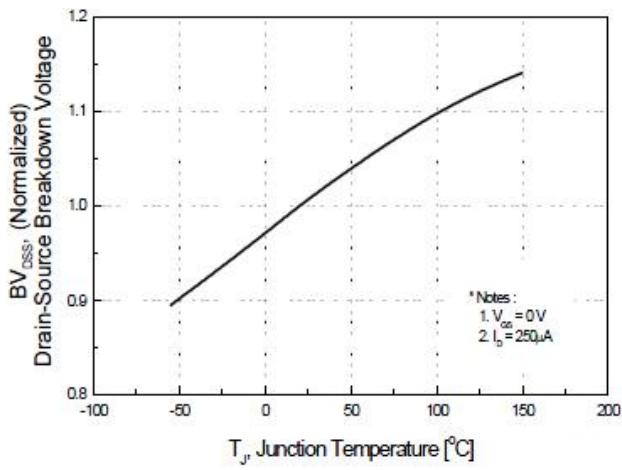


**Figure 6. Gate Charge Characteristics**

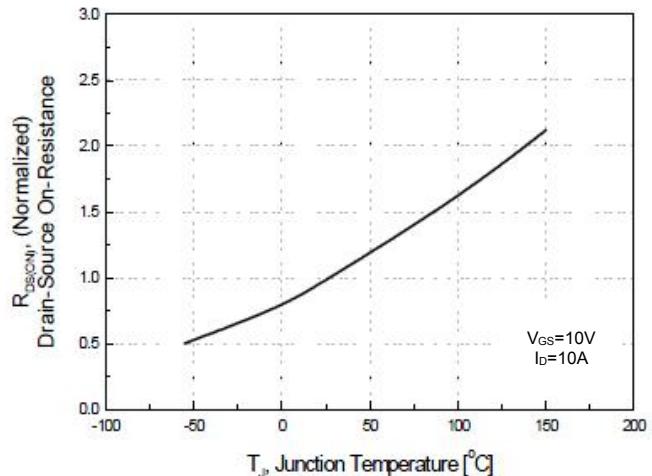


## ■ Typical Performance Characteristics (Cont.)

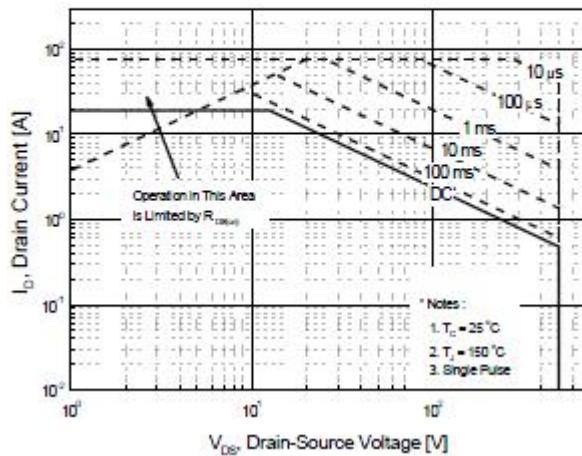
**Figure 7. Breakdown Voltage Variation vs. Temperature**



**Figure 8. On-Resistance Variation vs. Temperature**



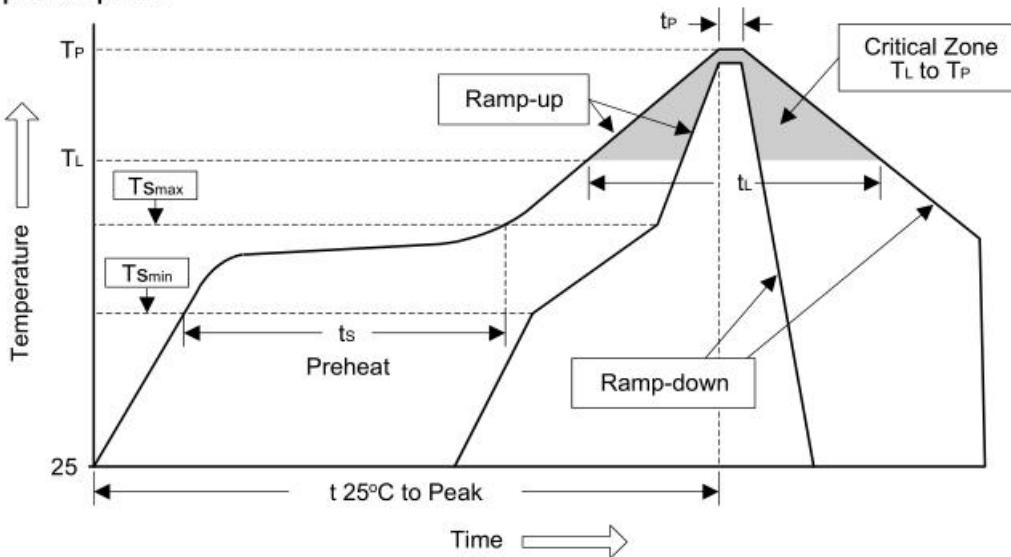
**Figure 9. Maximum Safe Operating Area**



## Soldering Methods for Products

| Profile Feature                            | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
|--|-------------------------|------------------|
| Average ramp-up rate(TL to TP)             | <3°C/sec                | <3°C/sec         |
| Preheat                                    | -                       | -                |
| -Temperature Min(Ts min)                   | 100°C                   | 150°C            |
| -Temperature Max(Ts max)                   | 150°C                   | 200°C            |
| -Time(min to max)(ts)                      | 60 to 120 sec           | 60 to 180 sec    |
| Ts max to TL                               | <3°C/sec                | <3°C/sec         |
| - ramp-up rate                             |                         |                  |
| Time maintained above:                     |                         |                  |
| -Temperature(TL)                           | 183°C                   | 217°C            |
| -Time(TL)                                  | 60 to 150 sec           | 60 to 150 sec    |
| Peak Temperature(TP)                       | 240°C+0/-5°C            | 250°C+0/-5°C     |
| Time within 5°C of actual Peak Temperature | 10 to 30 sec            | 20 to 40 sec     |
| Ramp-down Rate                             | <6°C/sec                | <6°C/sec         |
| Time 25 °C to Peak Temperature             | <6 minutes              | <8 minutes       |

Figure 1: Temperature profile

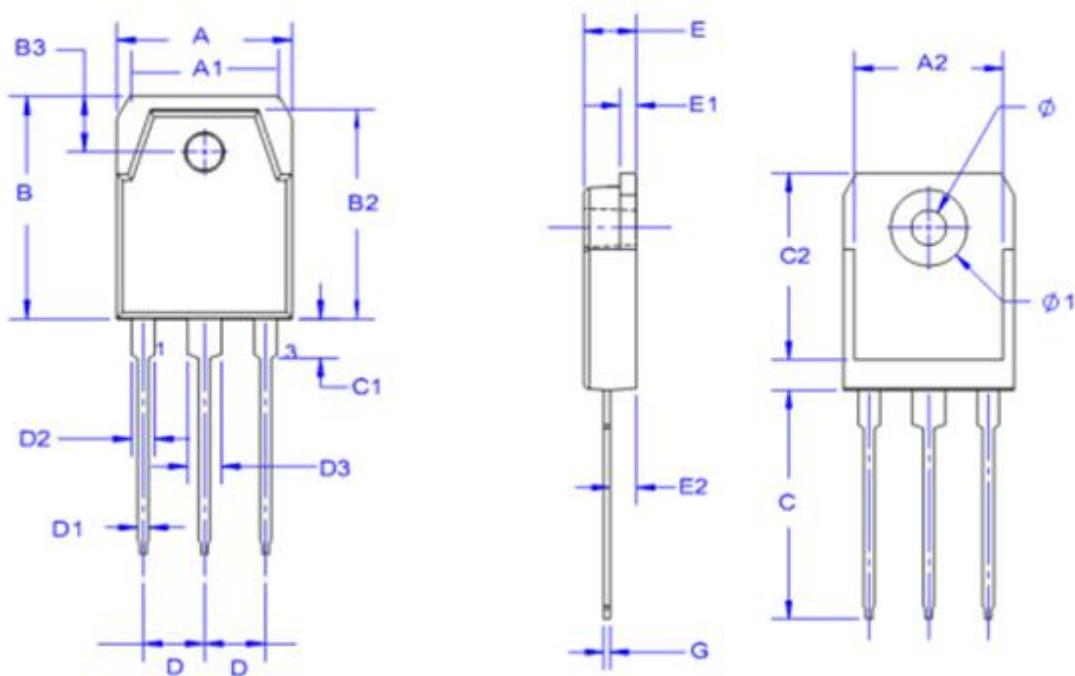


**Note :**

1. Storage environment: Temperature=10°C to 35@Humidity=45%±15%
- 2.Reflow soldering of surface-mount devices
- 3.Flow(wave) soldering(solder dipping)

| Products        | Peak Temperature            | Dipping Time    |
|-----------------|-----------------------------|-----------------|
| Pb devices      | $245^\circ C \pm 5^\circ C$ | $5sec \pm 1sec$ |
| Pb-free devices | $250^\circ C +0/-5^\circ C$ | $5sec \pm 1sec$ |

## Package Outline



**unit: mm**

| Symbol    | Min   | Max   | Symbol    | Min     | Max  |
|-----------|-------|-------|-----------|---------|------|
| <b>A</b>  | 15.40 | 15.80 | <b>D</b>  | 5.45Typ |      |
| <b>A1</b> | 13.40 | 13.80 | <b>D1</b> | 0.8     | 1.2  |
| <b>A2</b> | 13.4  | 13.8  | <b>D2</b> | 1.8     | 2.2  |
| <b>B</b>  | 19.70 | 20.10 | <b>D3</b> | 2.8     | 3.2  |
| <b>B1</b> | 13.50 | 13.90 | <b>E</b>  | 4.60    | 5.00 |
| <b>B2</b> | 12.56 | 13.06 | <b>E1</b> | 1.45    | 1.65 |
| <b>B3</b> | 3.40  | 3.80  | <b>E2</b> | 1.20    | 1.60 |
| <b>C</b>  | 19.70 | 20.30 | <b>G</b>  | 0.55    | 0.75 |
| <b>C1</b> | 3.30  | 3.70  | <b>Θ</b>  | 3.0     | 3.4  |
| <b>C2</b> | 16.20 | 16.80 | <b>Θ1</b> | 3.8     | 7.2  |

## ■ Important Notice

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